

**Notice of References Cited**

Application/Control No.

09/867,800

Applicant(s)/Patent Under  
Reexamination  
CHOI ET AL.

Examiner

Khanh B. Pham

Art Unit

2177

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,093,026 A	07-2000	Walker et al.	434/322
	B	US-2002/0029162 A1	03-2002	Mascarenhas, Desmond	705/10
	C	US-6,385,590 B1	05-2002	Levine, Philip	705/10
	D	US-2002/0065709 A1	05-2002	MacKenzie, Kenneth D.	705/10
	E	US-6,581,071 B1	06-2003	Gustman et al.	707/104.1
	F	US-6,567,786 B1	05-2003	Bibelnieks et al.	705/14
	G	US-6,618,746 B2	09-2003	Desai et al.	709/204
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Trindade, David, "Survey Data: Use of Scatter Plots for Displaying Scale and Consistency Factors", Proceeding of The Survey Research Methods Section, American Statistical Association, 1995, pages 99-101.
	V	Johnson et al. "Effects of Question Context and Response Order on Attitude Questions", Proceeding of The Survey Research Methods Section, American Statistical Association, 1998, pages 857-860.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.